

# Search Notes



Application/Control No.

09/848,101

Examiner

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Applicant(s)/Patent under Reexamination

GRUBER ET AL.

Art Unit

3629

## SEARCHED

Class	Subclass	Date	Examiner
705	1	6/06	DN
	7	↓	↓
	8	↓	↓
	9	↓	↓
	10	↓	↓
	14	↓	↓
	26	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	6/06	DN
Patent Pg Pub	↓	↓
II FOREIGN		
1. EPO		
2. JPO		
3. Denent		
III NPL dialogs	↓	↓